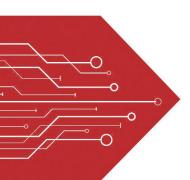
## MSKSEMI















**ESD** 

TVS

TSS

MOV

**GDT** 

**PLED** 

# Brodnet data speet

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#### **Description**

The STU417S uses advanced trench technology

to provide excellent  $R_{\text{DS}(\text{ON})}\text{, low gate charge and}$ 

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

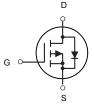


TO-252

#### **General Features**

 $V_{DS} = -40V I_{D} = -40A$ 

 $R_{DS(ON)}$  < 21 m $\Omega$  @  $V_{GS}$ =10V



P-Channel MOSFET

#### **Application**

Battery protection

Load switch

Uninterruptible power supply

#### Absolute Maximum Ratings (T<sub>C</sub>=25 ℃ unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-40	V
VGS	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	-40	А
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	-25	А
IDM	Pulsed Drain Current <sup>2</sup>	-144	А
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	30	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R⊕JA	Thermal Resistance Junction-ambient <sup>1</sup> 62		°C/W
R₀JC	Thermal Resistance Junction-Case <sup>1</sup> 2.5 °C		°C/W





### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
Off Characteristics							
BV <sub>DSS</sub>	Drain-Sourtce Breakdown Voltage	V <sub>GS</sub> =0V,I <sub>D</sub> =-250 μ A	-40			V	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> =0V, V <sub>DS</sub> =-40V			-1	μ <b>Α</b>	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ = $\pm$ 20V, $V_{DS}$ =0A			±100	nA	
On Characteristics							
$V_{GS(th)}$	GATE-Source Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250 μ A	-1.1	-1.7	-2.5	V	
R <sub>DS(ON)</sub>		V <sub>GS</sub> =-10V,I <sub>D</sub> =-20A		15	21		
	Drain-Source On Resistance	V <sub>GS</sub> =-4.5V,I <sub>D</sub> =-15A		21	32	m Ω	
G <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-5A	15			S	
Dynamic Characteristics							
C <sub>iss</sub>	Input Capacitance			2050			
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V, f=1MHz		260		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			150			
Switching Characteristics							
t <sub>d(on)</sub>	Turn-On Delay Time			10		ns	
t <sub>r</sub>	Rise Time	$V_{DS}$ =-20V, $R_L$ =1.6 $\Omega$		24		ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{GEN}$ =3 $\Omega$ , $V_{GS}$ =-10V		40		ns	
t <sub>f</sub>	Fall Time			9		ns	
$\mathbf{Q}_{\mathbf{g}}$	Total Gate Charge			45		nC	
$\mathbf{Q}_{gs}$	Gate-Source Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V,		6		nC	
$\mathbf{Q}_{gd}$	Gate-Drain "Miller" Charge	I <sub>D</sub> =-8A		11		nC	
Drain-Source Diode Characteristics							
V <sub>SD</sub>	Source-Drain Diode Forward Voltage	V <sub>GS</sub> =0V,I <sub>S</sub> =-10A,			-1.2	V	
I <sub>SD</sub>	Source-Drain Current(Body Diode)				-36	Α	

#### **Notes:**

<sup>1.</sup>Repetitive Rating: Pulse width limited by maximum junction temperature



#### **Typical Characteristics**

Figure 1. Power Dissipation

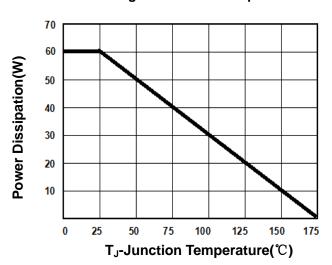


Figure 3. Output Characteristics

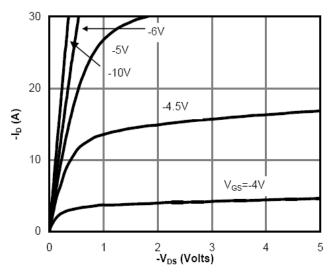


Figure 5. Capacitance

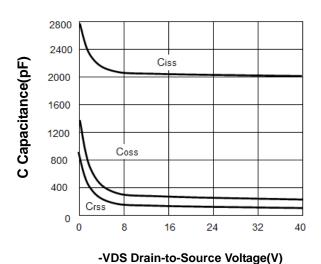


Figure2. Drain Current

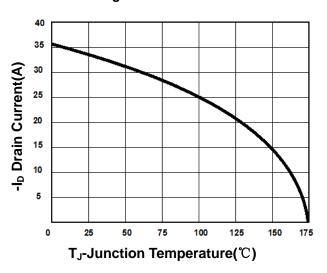


Figure 4. Transfer Characteristics

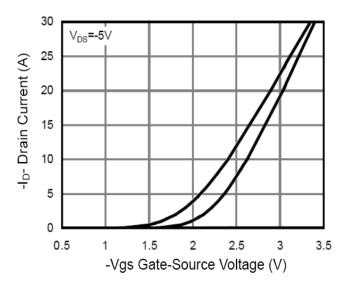


Figure 6. R<sub>DS(ON)</sub> vs Junction Temperature

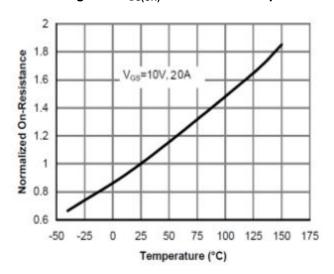




Figure 7. V<sub>GS(th)</sub> vs Junction Temperature

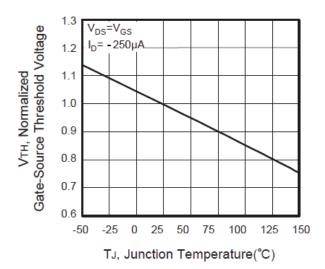


Figure 8. Gate Charge Waveforms

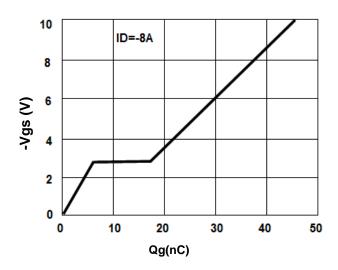
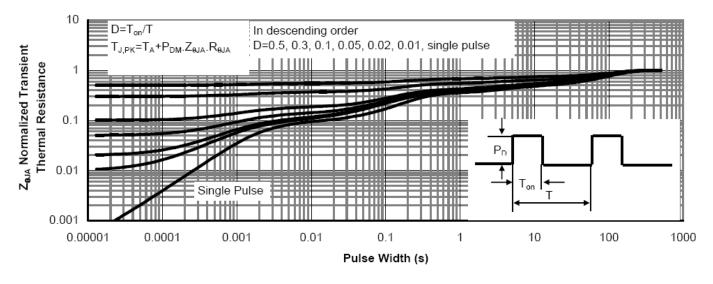
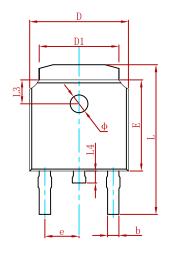


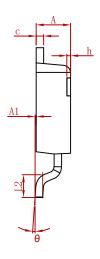
Figure 9. Normalized Maximum Transient Thermal Impedance

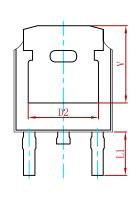




#### **PACKAGE MECHANICAL DATA**

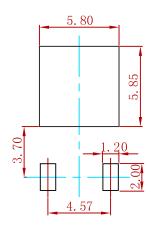






Cumhal	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.635	0.770	0.025	0.030	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830	REF.	0.190	REF.	
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.712	10.312	0.382	0.406	
L1	2.900	REF.	0.114	REF.	
L2	1.400	1.700	0.055	0.067	
L3	1.600	REF.	0.063	REF.	
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.250	REF.	0.207	REF.	

#### **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
STU417S	TO-252	2500



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